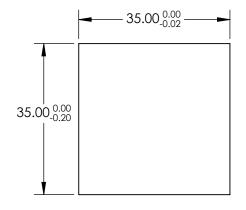
NOTES:

- 1. Substrate
- 2. CLEAR APERTURE AND COATING APERTURE ARE CENTERED ON SURFACES
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: Ravg ≥ 95% @ 400 690nm @ 0° AOI Tavg ≥ 90% @ 750 - 1200nm @ 0° AOI
 - S2: AR Coating: Ravg <1.0% @ 700 1150nm@ 0° AOI

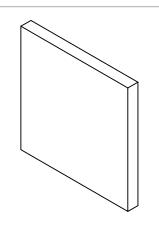


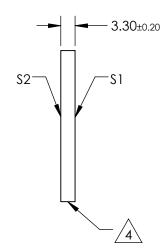
FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. Rohs Compliant









SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

| SHAPE | \$1 PLANO | S2 PLANO | | | | Edmund Option | CS® |
|------------------|----------------------|----------------------|------------------------|----|--------|--------------------------------|-----------------|
| SURFACE FLATNESS | 4 - 6λ | 4 - 6λ | THIRD ANGLE PROJECTION | | TITLE | 35 x 35mm, 0° AOI, COLD MIRROR | |
| SURFACE QUALITY | 80-50 | 80-50 | | | | | |
| BEVEL | PROTECTIVE AS NEEDED | PROTECTIVE AS NEEDED | ALL DIMS IN | mm | DWG NO | 64439 | SHEET 1 OF 1 |